



What Does Left Shifting Test Mean in the NI Ecosystem?

Ritesh Sharma – NI



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Luis Elias - Aliaro

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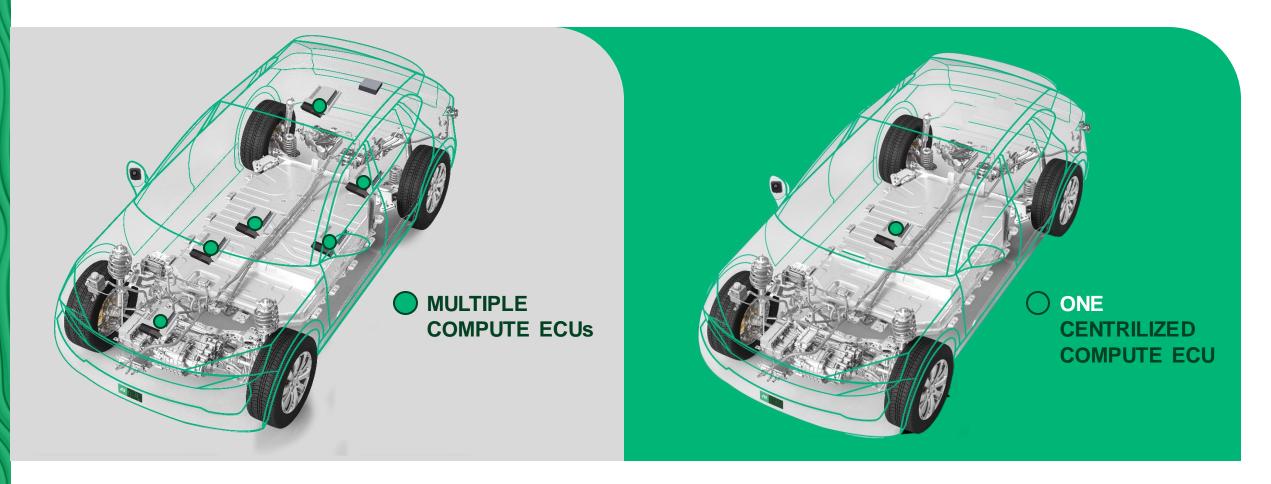
The Road to the Future is Paved with Software

Acceleration of EV and ADAS Roadmaps will Require New Tools and Process to Meet Demand

	2020	2030
Vehicle Production	77M New Vehicles	~100M New Vehicles (1.3x Increase)
Electrification	<5% Battery Electric	>30% Battery Electric (7x Increase)
(Contraction of the second sec	<15% L2 Autonomy or Above	>50% L2 Autonomy or Above (5x Increase)
Automotive companies plan to spend 45% of 2021 R&D budget on software - IHS SURVEY		

E/E Architecture Transformation

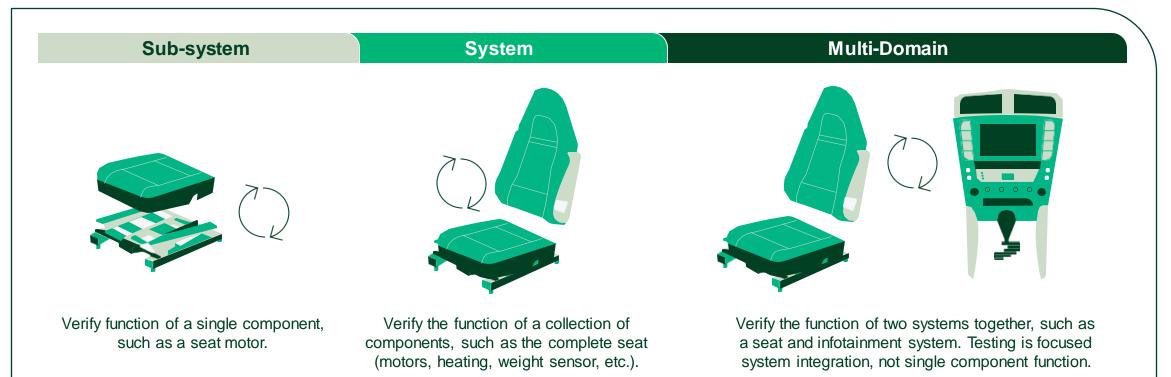
Moving Towards a Centralized E/E Architecture



Scaling From Subsystem to Multidomain HIL Testing Requirements

 HIGH CHANNEL COUNTS | ALWAYS EVOLVING DESIGNS | WIDE RANGE OF COMPONENTS TO TEST |

 INTEGRATE INTO VARIOUS VALIDATION TOOLS AND HIL SOLUTIONS | TEST REUSE | RECONFIGURABLE SYSTEMS | AND MORE



The Importance of Test

TECH TRANSPORTATION CARS

Honda recalls 608,000 vehicles for faulty software

Causing random reboots and problems with the backup camera By Sean O'Kane | @sokane1 | Aug 4, 2020, 2 06pm EDT

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Source: The Verge

AUT TRENDS

YOU ARE HERE HOME / SPECIAL / THE RECENT, WORRISOME SPIKE OF SOFTWARE-BASED DEFECTS IN VEHICLES

The Recent, Worrisome Spike of Software-Based Defects in Vehicles

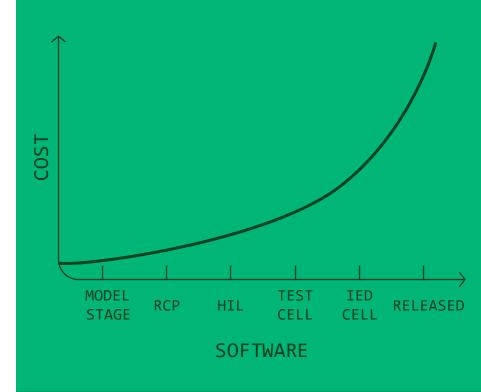
FEBRUARY 10, 2020 BY COLE MCKEON - LEAVE A COMMENT

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More and more technology is being integrated into vehicles in today's world. Much of this technology is complex, leading to significant problems, as seen in the skyrocketing number of software-related vehicle recalls in the past few years. These problems were especially pronounced in 2018, which was a record year for software-based defects in vehicles.

The new Stout Automotive Defect and Recall Report, released in late 2019, suggests the increase in software-based electronic defects was "the most significant trend of 2018". The report also reveals that 2018 had a record-breaking number of vehicle recalls based on software defects, for a total of 8 million-a higher total than the five previous years combined. 2018 also saw electronic defects accounting for the largest percentage of vehicles recalled, which was 26-percent or 6.3 million of all vehicle recalls.

Source: Auto Trends Magazine



Impact of Test Escapes

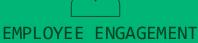




MARKET SHARE

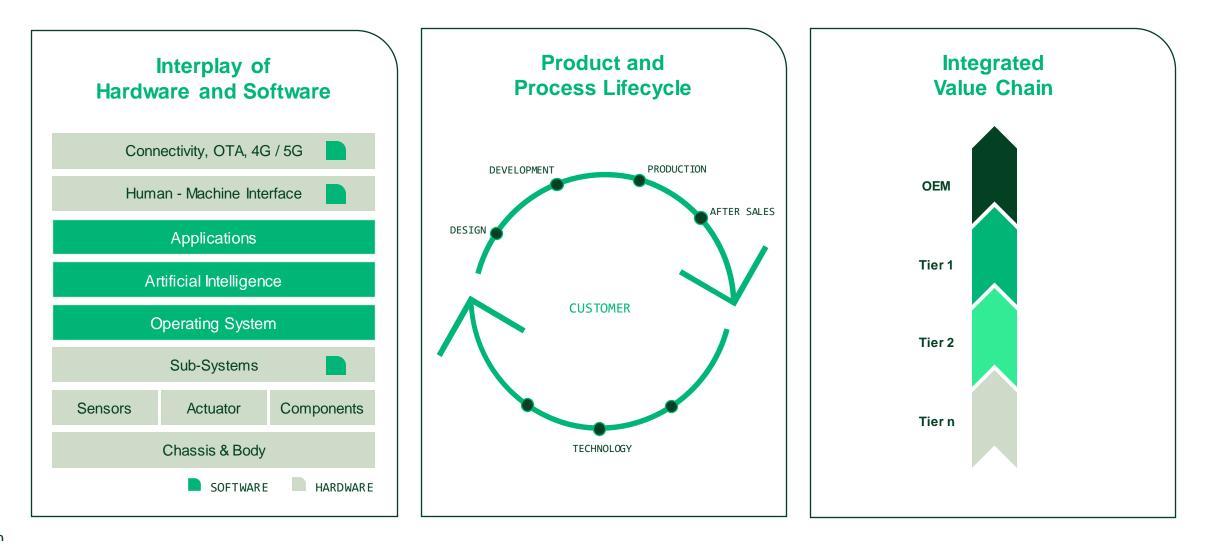


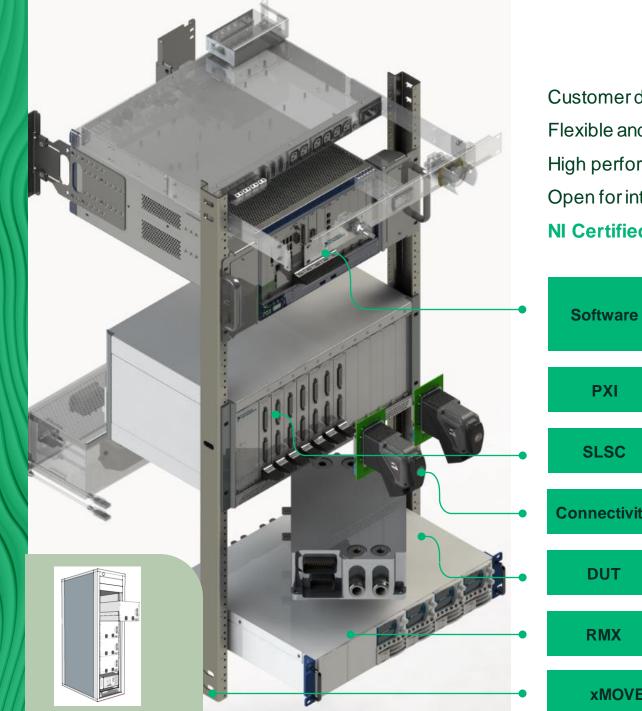
BRAND



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Automotive Companies Challenges





ALIARO +

Customer defined Flexible and scalable High performance Open for integration **NI Certified Partner and HIL expert ALIARO**

•	Software	SystemLink – data and s TestStand – test execut VeriStand – real-time te LabVIEW – programmin	ve st and model integration	
	ΡΧΙ	Measurements and I/O Communications Models in FPGA		
•	SLSC	Switch, Load, Signal Conditioning for fault insertion and routing signal paths.		
•	Connectivity	Cabling references for flexible connections to DUTs		
⊦•	DUT	ECU		
•	RMX	Programmable loads and power supplies		
•	xMOVE N	laster Rack Ra	ack infrastructure (PDU's, Cooling, E-St	ops etc.)

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xMove HIL Test System

Ready-to-use Real-Time Simulation System – Configurable For Your Application

The xMove Hardware-in-the-Loop (HIL) Reference System provides a hardware in-the-loop (HIL) test environment for dynamic, closed-loop testing of many transportation control systems. The concept was designed in 2006 and have been updated over the years to adapt new requirements.

Features

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Signal Conditioning of Analog I/O and Digital I/O
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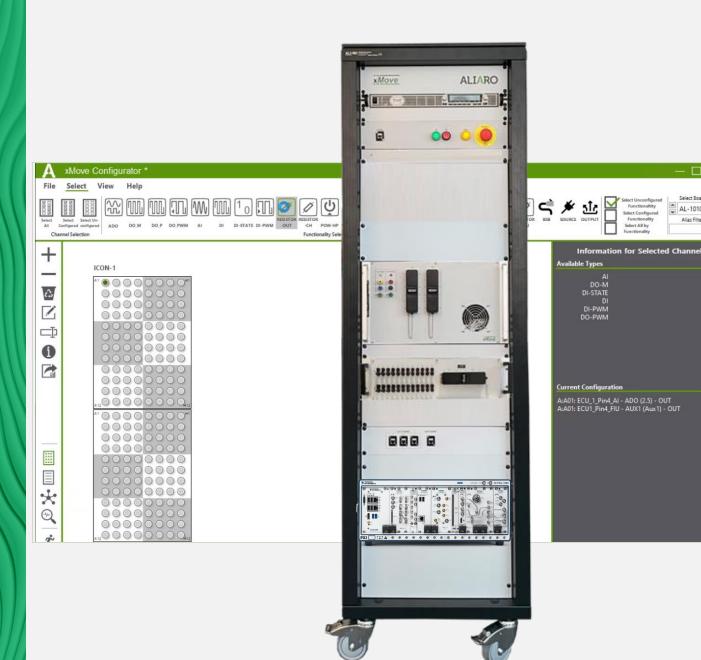
Real/sim. switching for testing real actuators with the system

Standard configuration with out-of-the-box functionality for rapid delivery and commissioning

Highly-customizable & modular architecture and interfaces to meet test demand

NI Software Ecosystem (VS, TS & LV) based, yet compatible with Python & other standards





I/O Flexibility and Reconfigurability

Select Board

AL-1010 Alias Filter

NI-ALIARO HIL approach provides flexibility based on standard components

Modularity at both I/O board and sub-system (I/O Box) levels

Flexibility as operational advantage to evolving requirements

Scalability maximizes test coverage from component to system level validation

Reconfigurability of signal type on pin level through software

Can be packed (custom-design) into a small cabinet

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I/O Modularity Concept

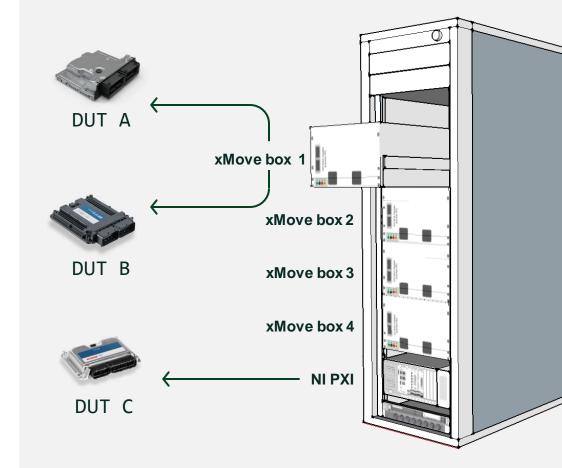
NI PXI (backend) defines the full superset of available resources (I/Os, automotive buses,...) of the system

Different DUTs may be interfaced to a **same xMove box**, selecting different software configurations

A **different xMove box** can be used to leverage **different backend resources** for specific setups (e.g. inverter test using FPGA)

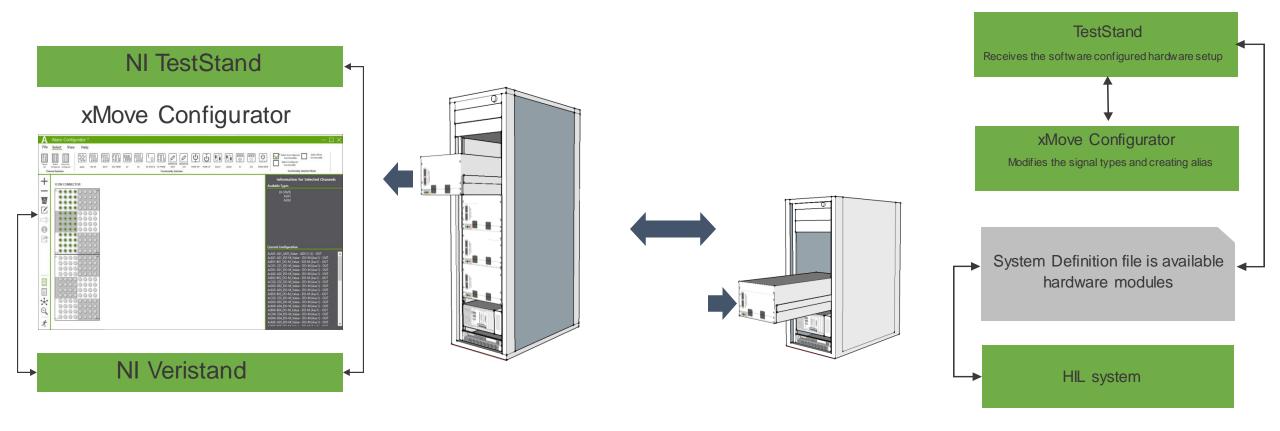
xMove boxes can be easily exchanged, even when the actual number of I/O differs

No need to differentiate harnesses and connectors





Software Based Configuration of the Test Systems

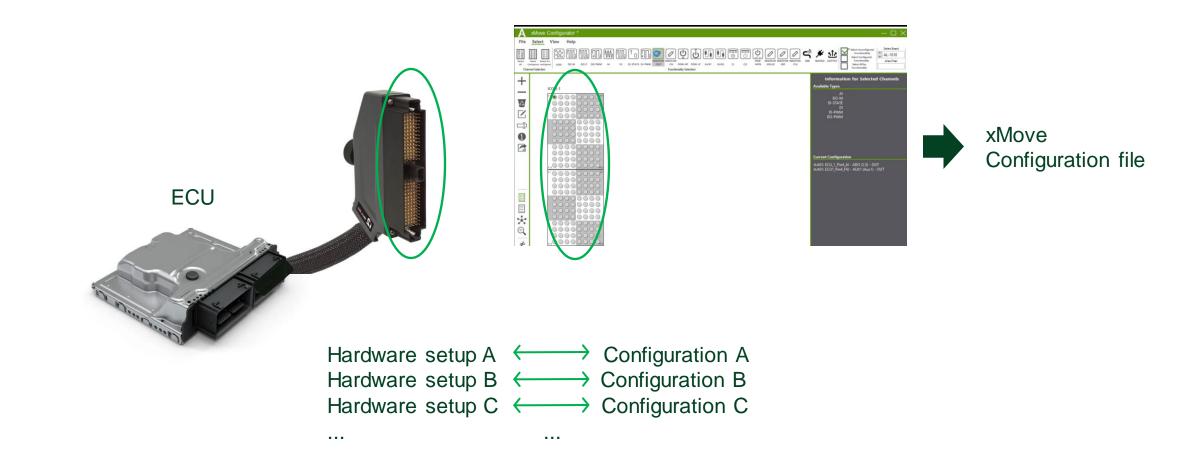


 Sub-System HIL
 Pre-defined system definition file for Sub-system HIL + xMove Configurator for setting signal types on PIN level do create unique setup

 System HIL
 Pre-defined system definition file for System HIL + xMove Configurator for setting signal types on PIN level unique setup.

(Merging the system definition files to create system HIL)

Software-Based Configuration Concept

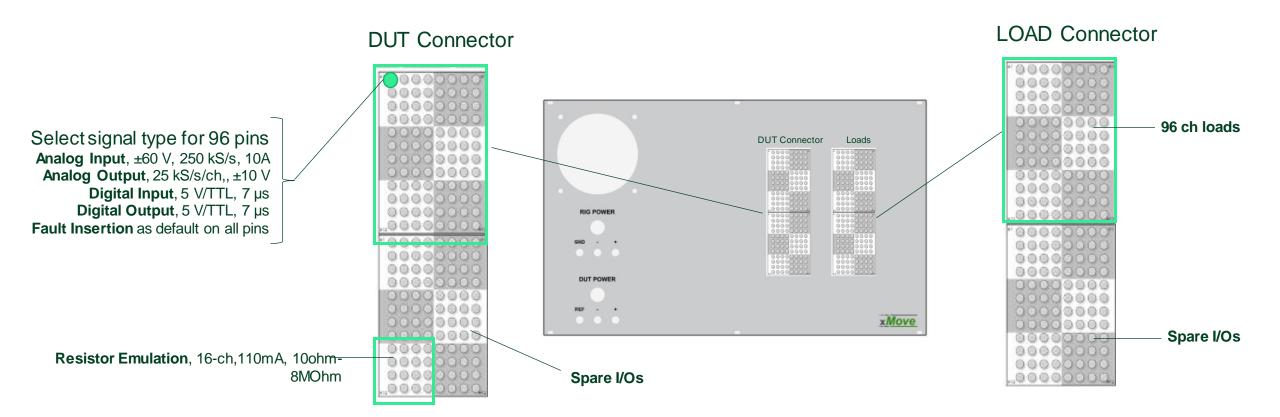


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xMove HIL Test System Differentiator

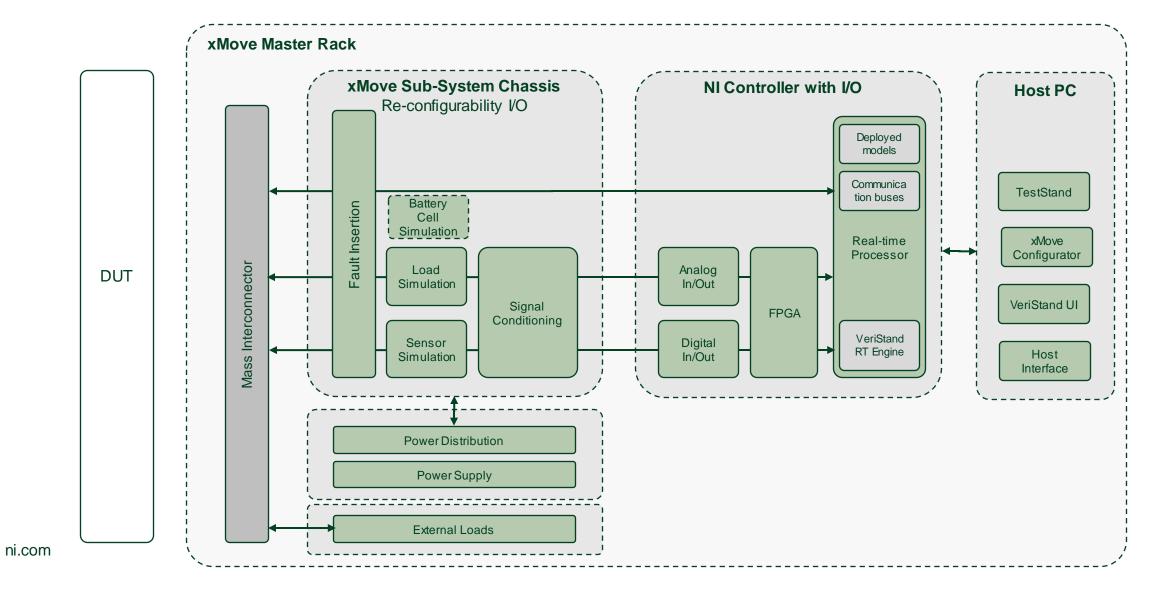
Each physical pin can switch between different signal types and by that reduce the time and cost between tests/projects/programs. Using xMove Configurator (SW) you can deploy new I/O allocations maps in minutes.





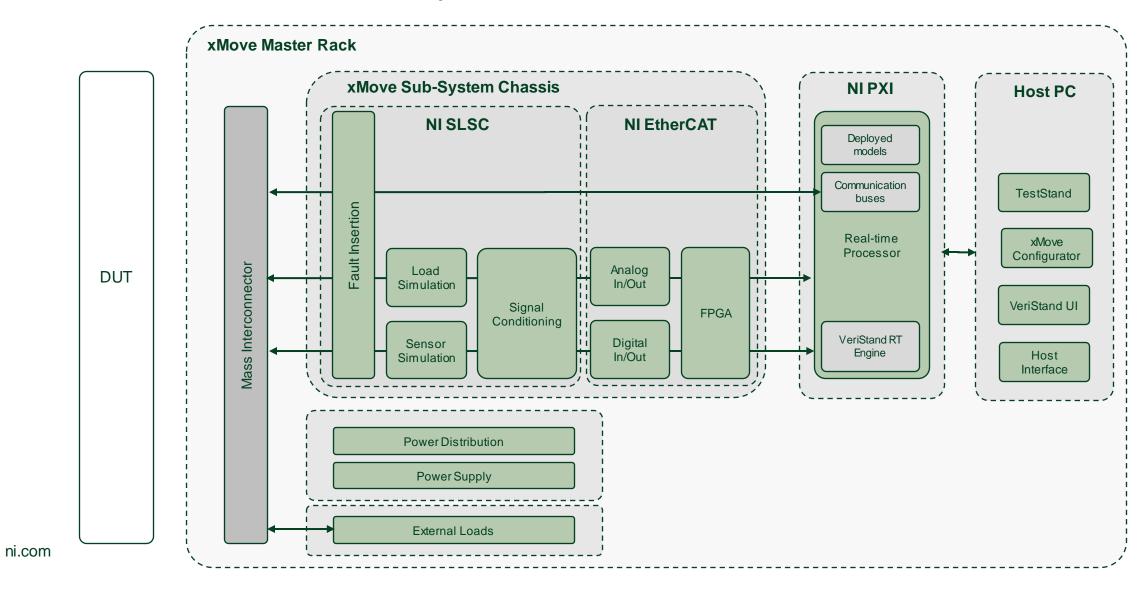
xMove HIL Test System-Level Hardware Architecture

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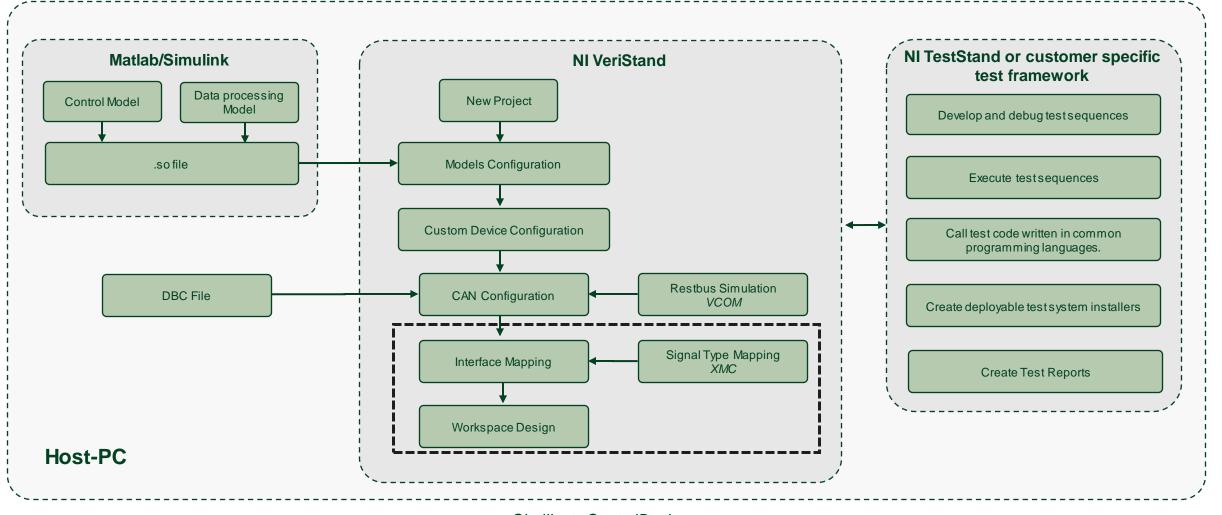


xMove HIL Test System-Level Hardware Architecture





NI HIL System Software Architecture



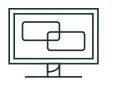
Similiar to ControlDesk

Similiar to AutomationDesk

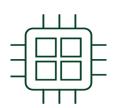
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NI HIL Solution Advantage

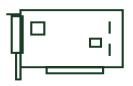
Software



Technology



Equipment



Model Integration Advanced Computing MATHWORKS COLLABORATION VERISTAND



I/O Breadth PXI SLSC

Operations



Customizability

FLEXIBLE SOFTWARE MODULAR I/O

Integration

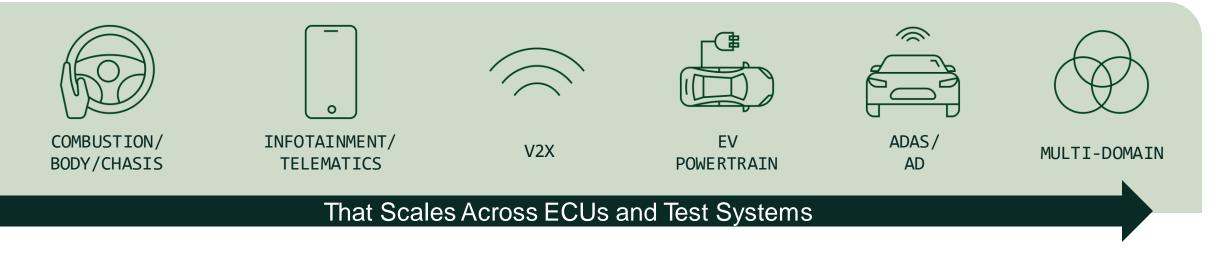
Integration

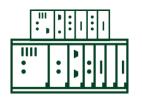
STANDARDS OPEN ECOSYSTEM

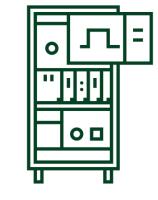
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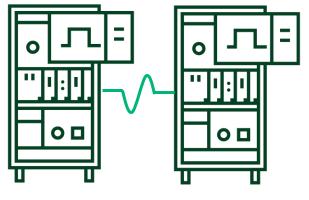
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Future Proof Your HIL System with an Open Turnkey Solution









DESKTOP HIL

COMPONENT HIL

SUB-SYSTEM HIL

SYSTEM INTEGRATION HIL



Question & Answers

